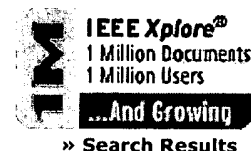


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Components, Packaging, and Manufacturing Technology, Part A, IEEE Transactions on [see also Components, Hybrids, and Manufacturing Technology, IEEE Transactions on] , Volume: 19 , Issue: 2 , June 1996

Pages:213 - 223

[\[Abstract\]](#) [\[PDF Full-Text \(1316 KB\)\]](#) **IEEE JNL****2 Numerical analysis of heating transient of electric contacts under short-circuit conditions***Bottauscio, O.; Crotti, G.; Farina, G.;*

Components, Hybrids, and Manufacturing Technology, IEEE Transactions on [see also IEEE Trans. on Components, Packaging, and Manufacturing Technology, Part A, B, C] , Volume: 16 , Issue: 5 , Aug. 1993

Pages:563 - 570

[\[Abstract\]](#) [\[PDF Full-Text \(568 KB\)\]](#) **IEEE JNL****3 Evaluation of welding deformation on ITER vacuum vessel***Nakahira, M.; Takahashi, H.; Inoue, O.; Koizumi, K.; Shibamura, K.; Tada, E.; Onozuka, M.; Ioki, K.;*

Fusion Engineering, 1999. 18th Symposium on , 25-29 Oct. 1999

Pages:245 - 248

[\[Abstract\]](#) [\[PDF Full-Text \(384 KB\)\]](#) **IEEE CNF****4 A method of evaluating flicker and flicker-reduction strategies in power systems***Jatskevich, J.; Wasynczuk, O.; Conrad, L.;*

Power Delivery, IEEE Transactions on , Volume: 13 , Issue: 4 , Oct. 1998

Pages:1481 - 1487

[\[Abstract\]](#) [\[PDF Full-Text \(688 KB\)\]](#) **IEEE JNL**